

<b>Notice of References Cited</b>	Application/Control No. 10/549,427		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,031,089 A	07-1991	Liu et al.	709/226
*	B	US-5,978,560 A	11-1999	Tan et al.	358/1.15
*	C	US-6,128,657 A	10-2000	Okanoya et al.	709/224
*	D	US-6,128,644 A	10-2000	Nozaki, Hideki	709/203
*	E	US-2002/0032777 A1	03-2002	Kawata et al.	709/226
*	F	US-2003/0163734 A1	08-2003	Yoshimura et al.	713/201
*	G	US-6,728,905 B1	04-2004	Gnanasivam et al.	714/43
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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